

Application No.	Applicant(s)	
10/658,401	NISHIYAMA ET AL.	
Examiner	Art Unit	
Tu M. Nguyen	3748	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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